

# MOSFET - Power, N-Channel, Shielded Gate, POWERTRENCH<sup>®</sup> 100 V, 50 A, 10.6 mΩ

# NTTFS010N10MCL

### **General Description**

This N-Channel POWETRENCH® MOSFET is produced using **onsemi**'s advanced POWERTRENCH® process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

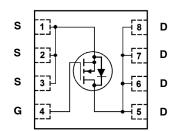
### **Features**

- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)} = 10.6 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 15 \text{ A}$
- Max  $r_{DS(on)} = 15.9 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 12 \text{ A}$
- 50% Lower Qrr than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

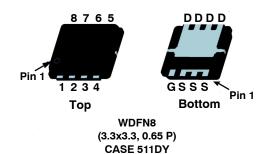
### **Applications**

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive

### **ELECTRICAL CONNECTION**



**N-Channel MOSFET** 



### **MARKING DIAGRAM**



N10L = Device Code
A = Assembly Location
Y = Year Code
WW = Work Week Code

### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

### **MOSFET MAXIMUM RATINGS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Symbol		Para	meter		Ratings	Unit
V <sub>DS</sub>	Drain to Source Voltage			100	V	
V <sub>GS</sub>	Gate to Source \	/oltage			±20	V
I <sub>D</sub>	Drain Current	-Continuous	T <sub>C</sub> = 25°C	(Note 5)	50	Α
		-Continuous	T <sub>C</sub> = 100°C	(Note 5)	32	1
		-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	10.7	1
		-Pulsed		(Note 4)	250	1
E <sub>AS</sub>	Single Pulse Ava	lanche Energy		(Note 3)	73	mJ
P <sub>D</sub>	Power Dissipatio	n	T <sub>C</sub> = 25°C		52	W
	Power Dissipatio	n	T <sub>A</sub> = 25°C	(Note 1a)	2.3	1
T <sub>J</sub> , T <sub>STG</sub>	Operating and St	orage Junction Tempe	rature Range		-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	2.4	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

### PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package	Reel Size	Tape Width	Quantity
NTTFS010N10MCLTAG	N10L	WDFN8 (3.3x3.3)	7"	12 mm	1500 Units

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

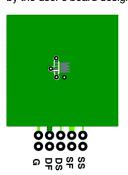
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
FF CHARACT	ERISTICS					•
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25°C		64		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V			1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
N CHARACTE	ERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 85 \mu A$	1.0	1.5	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 85 μA, referenced to 25°C		-5.3		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		9.1	10.6	mΩ
	Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 12 A		13.5	15.9	1
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 125°C		15.3	17.8	
9FS	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 15 A		54		S
YNAMIC CHA	RACTERISTICS					
C <sub>ISS</sub>	Input Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$		1530	2150	pF
C <sub>OSS</sub>	Output Capacitance	f = 1 MHz		625	875	1
C <sub>RSS</sub>	Reverse Transfer Capacitance			10	18	
R <sub>G</sub>	Gate Resistance		0.1	1.1	2.1	Ω

### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise noted) (continued)

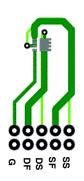
Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
WITCHING C	HARACTERISTICS		•			•	
t <sub>d(ON)</sub>	Turn – On Delay Time	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 15 A,			9	19	ns
t <sub>rd(ON)</sub>	Rise Time	V <sub>GS</sub> = 10 V, R <sub>GEN</sub> =	6 Ω		3	10	
t <sub>d(OFF)</sub>	Turn – Off Delay Time	1			28	45	
t <sub>f</sub>	Fall Time	1			5	10	1
Qg	Total Gate Charge	V <sub>GS</sub> = 0V to 10 V			22	30	nC
Qg	Total Gate Charge	V <sub>GS</sub> = 0V to 4.5 V			10		1
Q <sub>gs</sub>	Gate to Source Charge		V <sub>DD</sub> = 50 V		4		
$Q_{gd}$	Gate to Drain "Miller" Charge	1	I <sub>D</sub> = 15 A		3		
Q <sub>oss</sub>	Output Charge	V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 0	V		41		nC
Q <sub>sync</sub>	Total Gate Charge Sync	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 0 to 10 V			19		
RAIN-SOUR	CE DIODE CHARACTERISTICS						
$V_{SD}$	Source to Drain Diode Forward	$V_{GS} = 0 \text{ V}, I_{S} = 2 \text{ A}$	(Note 2)		0.7	1.2	V
	Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 15 \text{ A}$	(Note 2)		0.8	1.3	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 8 A, di/dt = 300 A	A/μs		22	36	ns
Q <sub>rr</sub>	Reverse Recovery Charge	7	Ī		35	56	nC
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 8 A, di/dt = 1000	A/μs		17	30	ns
Q <sub>rr</sub>	Reverse Recovery Charge	7	Г		79	126	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. R<sub>6,JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R<sub>6,CA</sub> is determined by the user's board design.



a) 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 73 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 3 mH,  $I_{AS} = 7$  A,  $V_{DD} = 100$  V,  $V_{GS} = 10$  V. 100% test at L = 0.5 mH,  $I_{AS} = 13$  A.
- Pulsed I<sub>D</sub> please refer to Figure 11 SOA graph for more details.
   Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

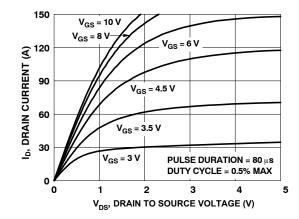


Figure 1. On Region Characteristics

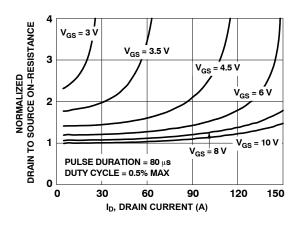


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

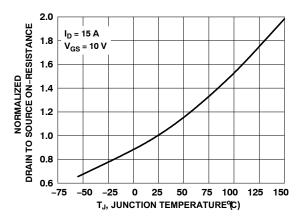


Figure 3. Normalized On Resistance vs. Junction Temperature

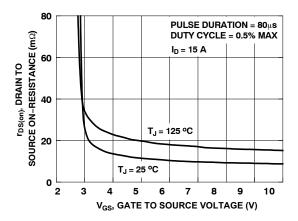


Figure 4. On-Resistance vs. Gate to Source Voltage

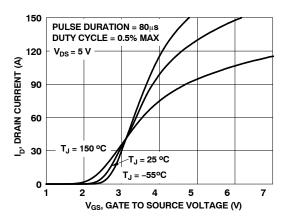


Figure 5. Transfer Characteristics

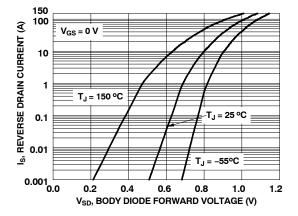


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

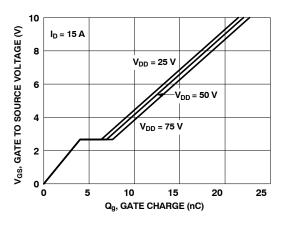


Figure 7. Gate Charge Characteristics

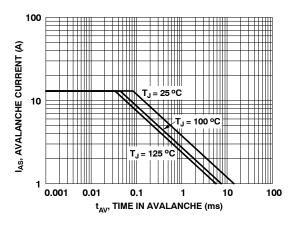


Figure 9. Unclamped Inductive Switching Capability

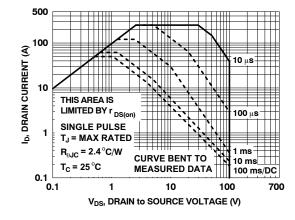


Figure 11. Forward Bias Safe Operating Area

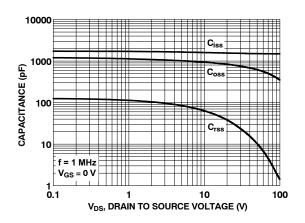


Figure 8. Capacitance vs. Drain to Source Voltage

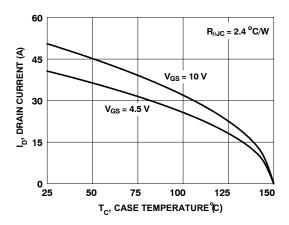


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

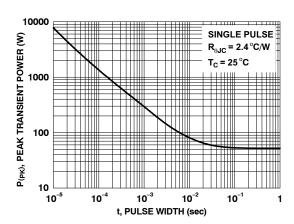


Figure 12. Single Pulse Maximum Power Dissipation

### TYPICAL CHARACTERISTICS (continued)

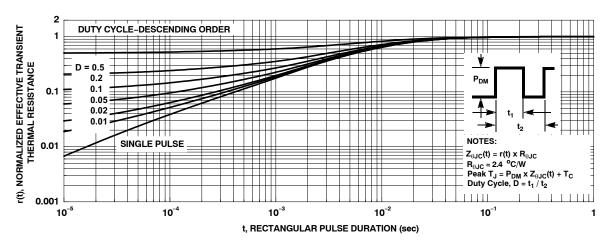


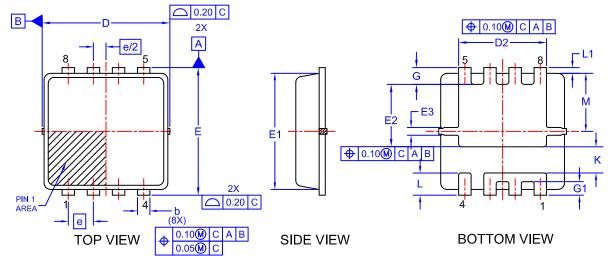
Figure 13. Junction-to-Case Transient Thermal Response Curve





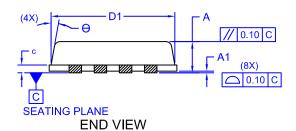
### WDFN8 3.3x3.3, 0.65P CASE 511DY ISSUE A

**DATE 21 AUG 2018** 



### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETERS
- 2. DIMENSIONS D1 & E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS.



	3.46
<u> </u>	2.38
0.78 (4X)	
0.75	2.51
0.57	4.10
0.60 (3)	1.00 1.00 
_	DMMENDED LAND PATTERN

# GENERIC MARKING DIAGRAM\*

O XXXX AYWW

 $\begin{array}{ll} \text{XXXX} = \text{Specific Device Code} \\ \text{A} &= \text{Assembly Location} \\ \text{Y} &= \text{Year Code} \end{array}$ 

WW = Work Week Code

	MILI	MILLIMETERS			
DIM	MIN	NOM	MAX		
Α	0.70	0.75	0.80		
A1	0.00	-	0.05		
b	0.23	0.33	0.43		
С	0.15	0.20	0.25		
D	3.20	3.30	3.40		
D1	2.95	3.13	3.30		
D2	1.98	2.20	2.40		
Е	3.20	3.30	3.40		
E1	2.80	3.00	3.15		
E2	1.40	1.60	1.80		
E3	0.15	0.25	0.40		
е	0	.65 BS	С		
G	0.30	0.43	0.55		
G1	0.25	0.35	0.45		
K	0.55	0.75	0.95		
L	0.35	0.52	0.65		
L1	0.06	0.15	0.30		
М	1.35	1.50	1.60		
Φ	0	-	12		

*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot " ■",
may or may not be present. Some products
may not follow the Generic Marking.

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